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EMC 1712093

File reference No.: 2017-12-12

Applicant:

Product: Charging Cable

Brand Name: N/A

Model No.: MC09

Test Standards: EN 55032:2015 EN61000-3-2:2014 EN 55024: 2010+A1:2015 EN 61000-3-3: 2013

Test result: The EMC testing has been performed on the submitted samples and found in compliance with council EMC Directive 2014/30/EU.

Approved By

Dated: Dece

December. 12, 2017

Results appearing herein relate only to the sample tested The technical reports is issued errors and omissions exempt and is subject to withdrawal at

SHENZHEN TIMEWAY TESTING LABORATORIES.

Room 512-519, 5/F., East Tower, Building 4, Anhua Industrial Zone, Futian District, Shenzhen, Guangdong China

Tel (755) 83448688 Fax (755) 83442996 Email: info@timeway-lab.com

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Special Statement:

The testing quality ability of our laboratory meet with "Quality Law of People's Republic of China" Clause 19.

The testing quality system of our laboratory meets with ISO/IEC-17025 requirements, which is approved by CNAS. This approval result is accepted by MRA of APLAC.

Our test facility is recognized, certified, or accredited by the following organizations:

CNAS-LAB Code: L2292

The EMC Laboratory has been assessed and in compliance with CNAS-CL01 accreditation criteria for testing Laboratories (identical to ISO/IEC 17025:2005 General Requirements) for the Competence of testing Laboratories.

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TABLE OF CONTENT

1.0	Ger	eral Details	5
	1.1	Test Lab Details	5
	1.2	Applicant Details	5
	1.3	Description of EUT	5
	1.4	Submitted Sample(s)	5
	1.5	Test Duration	5
	1.6	Additional information of EUT	6
	1.7	Test Engineer	6
2.0	List	of Measurement Equipment	7
	2.1	Conducted Emission Test	7
	2.2	Radiated Disturbance Test	7
	2.3	Harmonic & Flicker Test	7
	2.4	ESD Test	7
	2.5	RF field Strength Susceptibility	8
	2.6	Electrical Fast Transient/Burst (EFT/B) Immunity test	8
	2.7	Surge Test	8
	2.8	Conducted Immunity Test	8
	2.9	Power-frequency Magnetic Field	8
	2.10	Voltage Dips/Interruption Immunity Test	9
3.0	Tec	hnical Details	
	3.1	Investigations Requested	10
	3.2	Test Standards	10
	3.3	Performance Criteria	10
	3.4	Test standards and Results Summary Tables	.11
4.0	Ele	ctromagnetic Interference Test results	12
	4.1	Power line Conducted Emission Test	12
	4.2	Telecommunication ports Conducted Emission Test	15
	4.3	Radiated Disturbance Test	18
	4.4	Harmonic Current Emission Test	21
	4.5	Voltage Fluctuations & Flicker Test	23
5.0	Imr	nunity Test	25
	5.1	Electrostatic Discharge	
	5.2	RF field strength susceptibility (80MHz 1000MHz)	
	5.3	Electrical Fast Transient/Burst (EFT/B) immunity test	
	5.4	Surge test	
	5.5	Conducted Immunity test	
	5.6	Power-Frequency magnetic field test	
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	5.7	Voltage Dips/Interruptions immunity test	. 37
6.0	Prod	uct Labelling	. 39
	6.1	CE Mark label specification	. 39
	6.2	Mark Location: Rear enclosure	. 39
7.0	Pho	oto of testing	. 40

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1.0 General Details

1.1 Test Lab Details

SHENZHEN TIMEWAY TESTING LABORATORIES.

Room 512-519,5/F., East Tower, Building 4, Anhua Industrial Zone, Futian District, Shenzhen,

Guangdong China

Tel(086) 755-83448688 Fax (086) 755-83442996

Test Location

All tests were performed at:

SHENZHEN TIMEWAY TESTING LABORATORIES.

Room 512-519,5/F., East Tower, Building 4, Anhua Industrial Zone, Futian District, Shenzhen,

Guangdong China

Tel(086) 755-83448688 Fax (086) 755-83442996

No tests were sub-contracted.

1.2 Applicant Details

Applicant: Address:

Telephone:
Fax:
Manufacturer:

Address:

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Telephone:	
Fax:	

1.3 Description of EUT

Product:Charging CableBrand Name:N/AModel Number:MC09Adding Model Number:N/ARating: --Remark: ---

1.4 Submitted Sample(s)

1 Sample

1.5 Test Duration

Date of Receipt of Test Item: December 09, 2017

Date of Test: December 09, 2017~ December 12, 2017

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Page 6 of 44

1.6 Additional information of EUT

	Submitted	Not Available
User Manual		
Part List		
Circuit Diagram	\boxtimes	
Printed circuit board[PCB] Layout	\boxtimes	
Block Diagram		

1.7 Test Engineer

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The sample(s) tested by

ayout		
	STINGLA	Rad
	AL TIP	RE-TOL
Print Name	: Leo Lau/ Engine	er ×
	CERTIFICA	TOPA

PPPAAA

This test report is not valid without personnel's signatures of SHENZHEN TIMEWAY TESTING LABORATORIES

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2.0 List of Measurement Equipment

2.1 Conducted Emission Test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
EMI Test Receiver	ESH3	860905/006	RS	2017.06.11	1Year
Spectrum Analyzer	ESA-L1500A	US37451154	HP	2017.06.11	1Year
PULSE LIMITER	ESH3-Z2	100281	RS	2017.06.11	1Year
LISN	ESH3-Z5	100294	RS	2017.06.11	1Year
LISN	ESH3-Z5	100253	RS	2017.06.11	1Year

2.2 Radiated Disturbance Test

				Calibration	Calibration
Name	Model No	Serial No.	Manufacturer	Date	Cycle
EMI Test Receiver	ESVD	100008	RS	2017.06.11	1Year
Coaxial Switch	MP59B	M70585	ANRITSU	N/A	N/A
Spectrum Analyzer	8595E	3441A00893	HP	2017.06.11	1Year
Amplifier	8447D	2727A05017	HP	2017.06.11	1Year
Bilog Antenna	VULB9163	9163/340	Schwarebeck	2017.06.11	1Year

2.3 Harmonic & Flicker Test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
Harmonics Flicker Test System	PACS-1	72305	CI	2017.06.11	1Year
5K VA AC Power Source	5001iX	56060	CI	2017.06.11	N/A

2.4 ESD Test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
ESD Simulator	DITO	0404-24	EM TEST	2017.06.08	1Year

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2.5 RF field Strength Susceptibility

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
Signal Generator	SMT03	100059	RS	2017.06.11	1Year
Power Meter	NRVS		RS	2017.06.11	1Year
Voltage Probe	URV5-Z2	100012	RS	2017.06.11	1Year
Voltage Probe	URV5-Z2	100013	RS	2017.06.11	1Year
Power Amplifier	150W1000	300999	AR	2017.06.11	1Year
Power Amplifier	25S1G4AM1	305993	AR	2017.06.11	1Year
Field Probe	CBL6111C	2576	Holaday	2017.06.11	1Year
Bilog Antenna	MCDC		Chase	2017.06.11	1Year

Electrical Fast Transient/Burst (EFT/B) Immunity test 2.6

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
EFT Generator	UCS 500 M4	0304-42	EM TEST	2017.06.11	1Year
Power Source	MV2616	0104-14	EM TEST	2017.06.11	1Year

2.7 Surge Test

Name	Model No.	Serial No.	Manufacturer	Calibration Date	Calibration Cycle
Ultra Compact	UCS 500			2017.06.11	
Simulator	M4	0304-42	EM TEST		1Year
Power Source	MV2616	0104-14	EM TEST	2017.06.11	1Year

2.8 Conducted Immunity Test

					Calibration	Calibration
Name		Model No.	Serial No.	Manufacturer	Date	Cycle
Continuous	Wave				2017.06.11	
Simulator		CWS 500C	0407-05	EM TEST		1 Year

2.9 Power-frequency Magnetic Field

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
Continuous Wave	UCS 500 M4	0304-42		2017.06.11	
Simulator	UCS 500 M4	0304-42	EM TEST		1 Year
Power Source	MV 2616	0104 14		2017.06.11	
Network	MV 2616	0104-14	EM TEST		1 Year
Current Transformer	MC2630		EM TEST	2017.06.11	1 Year

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Magnetic CoilMS1000304-42EM	TEST 2017.06.11 1 Year
-----------------------------	------------------------

2.10 Voltage Dips/Interruption Immunity Test

				Calibration	Calibration
Name	Model No.	Serial No.	Manufacturer	Date	Cycle
Ultra Compact				2017.06.11	
Simulator	UCS 500 M4	0304-42	EM TEST		1Year
Power Source	MV2616	0104-14	EM TEST	2017.06.11	1Year

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3.0 Technical Details

3.1 Investigations Requested

Perform Electromagnetic Interference [EMI] & Electromagnetic Susceptibility[EMS] tests for CE Marking

3.2 Test Standards

	Test Standards				
EN 55032:2015	Electromagnetic compatibility of multi	Electromagnetic compatibility of multimedia equipment - Emission Requirements			
ENIC1000 2 2:2014	Electromagnetic compatibility(EMC)-	Part 3-2:Limits-Limits for harmonic current			
EN61000-3-2:2014	emissions(equipment input current \leq	16A per phase)			
	Electromagnetic compatibility (EMC	C)- Part 3-3:Limits-Limitation of voltage			
EN 61000-3-3:2013	changes, Voltage fluctuations and flick	ter in public low-voltage supply systems. For			
EN 01000-5-5.2015	equipment with rated current $\leq 16A$ per phase and not subject to conditional				
	connection				
EN	Information technology equipment -	- Immunity characteristics - Limits and			
55024:2010+A1:2015	methods of measurement				
	EN 61000-4-2:2009	Electrostatic discharge			
	EN 61000-4-3:2006	RF field strength susceptibility			
	EN 61000-4-4:2012	Electrical Fast transients			
	EN 61000-4-5:2014	Surge			
	EN 61000-4-6:2009	Conducted susceptibility			
	EN 61000-4-8:2010	Power-frequency Magnetic Field			
	EN 61000-4-11:2004	Dips/Voltage Interruption Variation			

3.3 Performance Criteria

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Criterion	Description
Α	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
В	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
С	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

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3.4 Test standards and Results Summary Tables

Test Condition	Test Requirement	Test Method	Test Result				
EMISSION Results Summary							
Conducted Emission on AC Mains,	EN 55032:2015	EN 55032:2015	Pass				
150kHz to 30MHz			Pass				
Conducted Emission on at	EN 55032:2015	EN 55032:2015					
telecommunication ports,			N/A				
150KHz to 30MHz							
Radiated Emissions,	EN 55032:2015	EN 55032:2015	Pass				
30MHz to 1GHz			Pass				
Harmonic Emissions on AC supply	EN61000-3-2:2014	EN61000-3-2:2014	N/A				
Voltage fluctuations on AC supply	EN 61000-3-3: 2013	EN 61000-3-3: 2013	N/A				
	IMMUNITY Results Sum	mary					
Electrostatic Discharge	EN 55024: 2010+A1:2015	EN 61000-4-2: 2009	Pass				
Electrical Fast transients	EN 55024: 2010+A1:2015	EN 61000-4-4: 2012	Dara				
/Burst Immunity			Pass				
RF field strength susceptibility	EN 55024: 2010+A1:2015	EN 61000-4-3: 2006	Pass				
Surge	EN 55024: 2010+A1:2015	EN 61000-4-5: 2014	Pass				
Conducted susceptibility	EN 55024: 2010+A1:2015	EN 61000-4-6: 2009	Pass				
Power-frequency Magnetic Field	EN 55024: 2010+A1:2015	EN61000-4-8: 2010	N/A				
Dips/Voltage Interruption Variation	EN 55024: 2010+A1:2015	EN 61000-4-11: 2004	Pass				

Note: N/A-Not applicable

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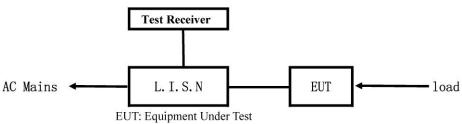
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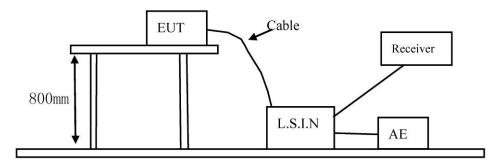
4.0 Electromagnetic Interference Test results

- 4.1 Power line Conducted Emission Test
- 4.1.1 Schematics of the test



4.1.2 Test Method:

The test was performed in accordance with EN 55032:2015 Block diagram of Test setup



4.1.3 Power line conducted Emission Limit

	Limits dB(µ V)						
Frequency(MHz)	Class A I	Equipment	Class B Equipment				
	Quasi-peak Level	Average Level	Quasi-peak Level	Average Level			
$0.15~\sim~0.50$	79.0	66.0	66.0~56.0*	56.0~46.0*			
$0.50~\sim~5.00$	73.0	60.0	56.0	46.0			
$5.00 \sim 30.00$	73.0	60.0	60.0	50.0			

Notes: 1. *decreasing linearly with logarithm of frequency.

2. The lower limit shall apply at the transition frequencies

4.1.4 Test Results

Limits for Conducted Emission test, Please refer to limit line (Quasi-peak)and Average in the following diagram labelled as (QP)&AV

Remark:

Calculated measurement uncertainty=3.6dB

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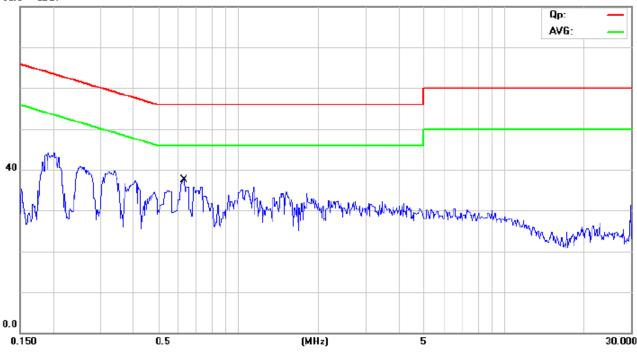
A: Conducted Emission on Live Terminal (150kHz to 30MHz)
EUT Operating Environment

 Temperature: 26°C
 Humidity: 65%RH
 Atmospheric Pressure: 101 kPa

EUT set Condition: Charging

 Equipment Level: Class B
 Results: Pass
 Please refer to following diagram for individual

80.0 dBuV



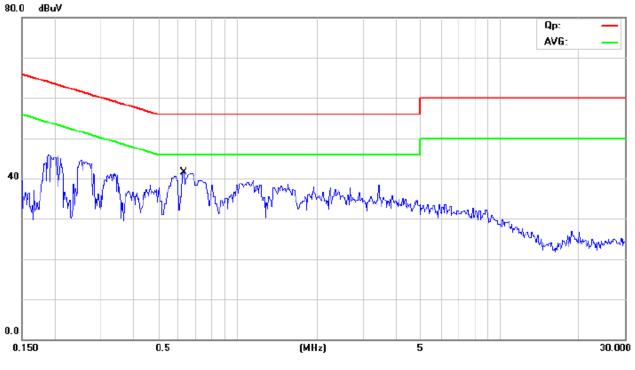
No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1 *	0.6240	22.40	10.43	32.83	56.00	-23.17	QP	
2	0.6240	-1.90	10.43	8.53	46.00	-37.47	AVG	

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B: Conducted Emission on Neutral Terminal (150kHz to 30MHz) EUT Operating Environment Temperature: 26°C Humidity: 65%RH Atmospheric Pressure: 101 kPa EUT set Condition: Charging Equipment Level: Class B Results: Pass Please refer to following diagram for individual



No. Mk.	Freq.	Reading Level		Measure- ment	Limit	Over		
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1 *	0.6251	27.40	10.43	37.83	56.00	-18.17	QP	
2	0.6251	1.40	10.43	11.83	46.00	-34.17	AVG	

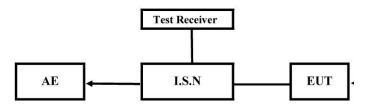
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4.2 Telecommunication ports Conducted Emission Test

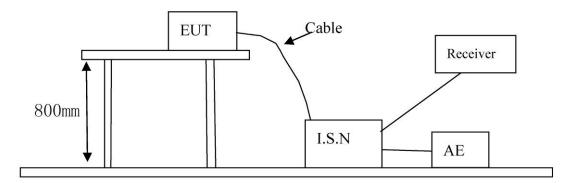
4.2.1 Schematics of the test



EUT: Equipment Under Test

4.2.2 Test Method:

The test was performed in accordance with EN 55032:2015 Block diagram of Test setup



4.2.3 Telecommunication ports conducted Emission Limit

		Class A	Limits		Class B Limits			
Frequency(MHz)	Quasi-pe	i-peak Level Average Level		Quasi-peak Level		Average Level		
Trequency(withz)	Vlotage	Current	Vlotage	Current	Vlotage	Current	Vlotage	Current
	dB(uV)	dB(uA)	dB(uV)	dB(uA)	dB(uV)	dB(uA)	dB(uV)	dB(uA)
$0.15~\sim~0.50$	97 to 87	53 to43	84 to74	40 to 30	84 to 74	40 to30	74 to64	30 to 20
$0.50~\sim~30.00$	87	43	74	30	74	30	64	20

Notes: 1. *decreasing linearly with logarithm of frequency.

2. The tighter limit shall apply at the transition frequencies

4.2.4 Test Results

Limits for Conducted Emission test, Please refer to limit line (Quasi-peak)and Average in the following diagram labelled as (QP)&AV

Remark:

Calculated measurement uncertainty=1.9dB

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A: Conducted Emission on Telecommunication port (150kHz to 30MHz)

EUT Operating Environment

Temperature: 25°C Humidity: 75 %RH Atmospheric Pressure: 101 kPa

EUT set Condition: Normal operation mode

Equipment Level: Class B

Results: N/A

Please refer to following diagram for individual

Frequency	Port	Reading(dBµV)	Limit(dBµV)	
(MHz)	Polt	Quasi-peak	Average	Quasi-peak	Average
	LAN				
	LAN				

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B: Conducted Emission on Telecommunication port (150kHz to 30MHz)

EUT Operating Environment

Temperature: 25°C Humidity: 75 %RH

Atmospheric Pressure: 101 kPa

EUT set Condition: Normal operation mode Equipment Level: ClassB

Results: N/A

Please refer to following diagram for individual

Frequency	Port	Reading(dBµA)	Limit(dBµA)		
(MHz)	Poit	Quasi-peak	Average	Quasi-peak	Average	
	LAN					

Note: No such port, not applicable.

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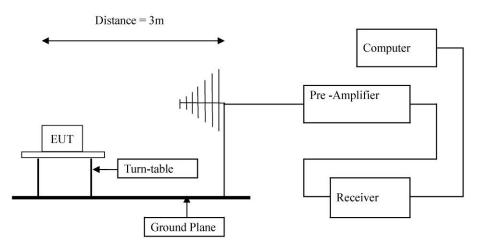
4.3 Radiated Disturbance Test

4.3.1 Schematics of the test



4.3.2 Test Method:

The test was performed in accordance with EN 55032:2015 Block diagram of Test setup



4.3.3 Radiated Disturbance Test Limit

Frequency Range (MHz)	Quasi-Peak limits (dB µ V/m)		
	Class A Limits	Class B Limits	
30-230	50.00	40.00	
230-1000	57.00	47.00	

Note: The lower limit shall apply at the transition frequencies

4.3.4 Test result

Limits for Radiated Disturbance test, Please refer to limit line (Quasi-peak) in the following diagram labelled as (QP)

Remark:

Calculated measurement uncertainty=4.7dB

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A: Radiated Disturbance (30MHz----1000MHz) EUT Operating Environment

Temperature: 25°C Humidity: 55%RH

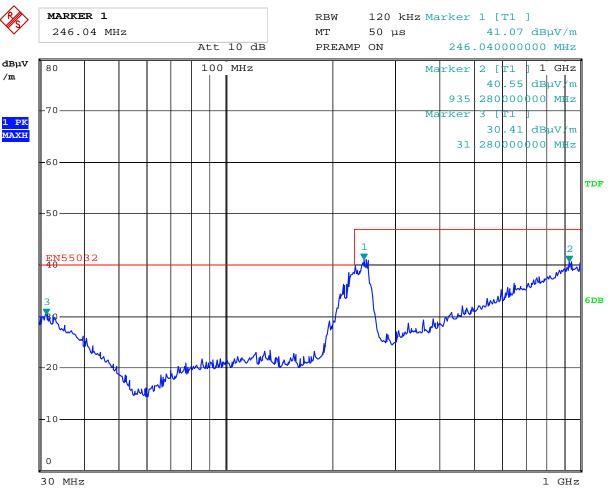
Atmospheric Pressure: 101 kPa

EUT set Condition: Charging

Equipment Level: Class B

Results: Pass

Please refer to following diagram for individual



Frequency (MHz)	Level@3m (dBµV/m)	Antenna Polarity	Limit@3m (dBµV/m)
246.040	41.07	Н	47.00
935.280	40.55	Н	47.00
31.280	30.41	Н	40.00

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B: Radiated Disturbance (30MHz----1000MHz) EUT Operating Environment

Temperature: 25°C Humidity: 55%RH

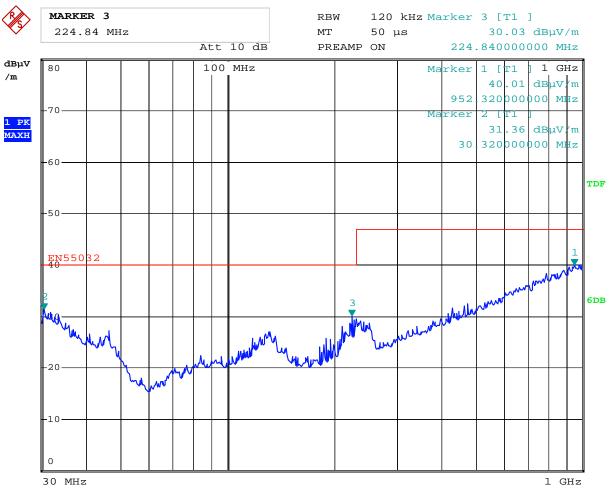
Atmospheric Pressure: 101 kPa

EUT set Condition: Charging

Equipment Level: Class B

Results: Pass

Please refer to following diagram for individual



Date:	11.DEC.2017	17:11:25

Frequency (MHz)	Level@3m (dBµV/m)	Antenna Polarity	Limit@3m (dBµV/m)
224.840	30.03	V	40.00
952.320	40.01	V	47.00
30.320	31.36	V	40.00

Note: Pre-scanning with PK detector and final measurement with QP detector

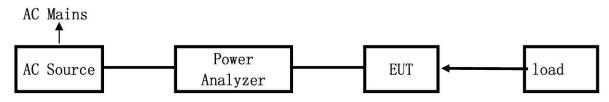
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4.4 Harmonic Current Emission Test

4.4.1 Schematic of the test



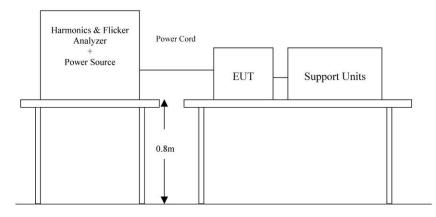
EUT: Equipment Under Test

4.4.2 Test Method:

The test was performed in accordance with EN61000-3-2:2014

*: The Level of the product is : CLASS D

Block diagram of Test setup



4.4.3 Limits of Harmonic Current Emission For Class A

Harmonic order	Maximum permissible harmonic current				
n	A				
Odd harmonics					
3	2,30				
5	1,14				
7	0,77				
9	0,40				
11	0,33				
13	0,21				
15 ≤ n ≤ 39	0,15 <u>15</u>				
Even har	monics				
2	1,08				
4	0,43				
6	0,30				
8 ≤ n ≤ 40	0,23 8				

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4.4.4 Test Results

Please refer to the following pages Harmonic Current Emission Test

EUT Operating Environment

Temperature: 25°C Humidity: 53%RH

Atmospheric Pressure: 101 Kpa

EUT set Condition: Results: N/A

Please refer to following diagram for individual

Harmonic results as a% of the limits

No	(Test result/Limit)%	No	(Test result/Limit)%	No	(Test result/Limit)%	No	(Test result/Limit)%
1		11	Tesuri Linney/o	21	Tesure Enney/o	21	Tesure Enney/o
1		11		21		31	
2		12		22		32	
3		13		23		33	
4		14		24		34	
5		15		25		35	
6		16		26		36	
7		17		27		37	
8		18		28		38	
9		19		29		39	
10		20		30		40	

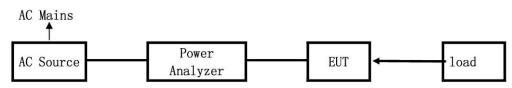
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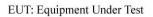
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4.5 Voltage Fluctuations & Flicker Test

4.5.1 Schematic of the test

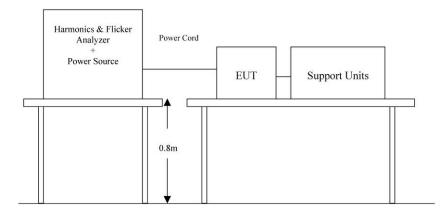




4.5.2 Test Method:

The test was performed in accordance with EN 61000-3-3:2013

Block diagram of Test setup



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4.5.3 Test Results

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Result: N/A

Please refer to following diagram for individual

Maximum Occurring Levels:

Ut: 230.1	(EUT Test	RMS Vol	tage)
Pst:	Limit=	1.0	(The Highest short Term Flicker Value)
Plt:	Limit=	0.65	(The Highest Long Term Flicker Value)
dt(%):	Limit=	3.3%	(The Highest instantaneous Voltage Change (10ms))
dc(%):	Limit=	3.3%	(The highest Relative steady state voltage change (1sec))
dmax:	Limit=	4%	(The highest Max Relative voltage change)
Tdt:	Limit=	500ms	(The Max Time(in milli-sec) that dt exceeds 3%)

The report refers only to the sample tested and does not apply to the bulk.

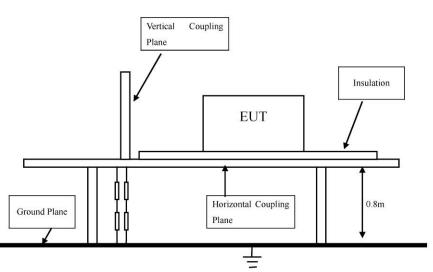
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5.0 Immunity Test

- 5.1 Electrostatic Discharge
- 5.1.1 Schematic of the test



5.1.2 Test method

The test was performed in accordance with EN 61000-4-2: 2009

5.1.3 Test severity

 \pm 4Kv for direct & in-direct Contact Discharge

 \pm 8Kv for air Discharge

Performance Criterion Require: **B** (Please see following table)

5.1.4 Susceptibility performance Criteria and Severity level

Criterion	Description
А	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
В	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
С	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

Severity Level

Level	Test Voltage Direct & in-direct contact	Test Voltage Air
	Discharge (Kv)	discharge(Kv)
1	$\pm 2 \text{Kv}$	$\pm 2 K v$
2	$\pm 4 \mathrm{Kv}$	$\pm 4 Kv$
3	$\pm 6 \mathrm{Kv}$	$\pm 8 Kv$
4	$\pm 8 \mathrm{Kv}$	±15Kv

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5.1.5 Test Result

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EUT Operating Environment

Temperature: 25°C Humidity: 53%RH Atmospheric Pressure: 101 Kpa Please refer to the following table for individual results.

Location	Discharge Method	Test Voltage	Results
НСР	In-Direct	$\pm 2kV, \pm 4kV$	Pass
VCP	In-Direct	$\pm 2kV, \pm 4kV$	Pass
Screw	Contact Discharge	$\pm 2kV, \pm 4kV$	Pass
Function key	Air Discharge	$\pm 2kV, \pm 4kV, \pm 8kV$	Pass
Gap	Air Discharge	$\pm 2kV, \pm 4kV, \pm 8kV$	Pass
Enclosure	Air Discharge	± 2 kV, ± 4 kV, ± 8 kV	Pass
Cable	Air Discharge	$\pm 2kV, \pm 4kV, \pm 8kV$	Pass
Near USB port	Air Discharge	$\pm 2kV, \pm 4kV, \pm 8kV$	Pass

Remark: Calculated measurement uncertainty= 0.2kV

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5.2 RF field strength susceptibility (80MHz----- 1000MHz)

5.2.1 Schematics of the test



5.2.2 Test Method:

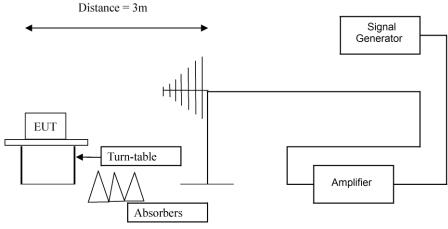
The test was performed in accordance with EN 61000-4-3:2006

Severity: Level 2 (3V/m)

Modulation: 80% AM

Performance Criterion Require: A (Please see following table)

Block diagram of Test setup



5.2.3 Susceptibility performance Criteria and severity Level

Susceptibility performance Criteria

Criterion	Description
Α	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
В	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
С	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

Severity Level

Level	Field Strength (V/m)		
1	1		
2	3		
3	10		

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5.2.4 Test Result:

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EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 kPa Please refer to the following table for individual results.

Frequency (MHz)	Face	Polarity	Level (V/m)	Dwell Time(s)	Sweep Rate (%)	Results
80-1000	0°	Horizontal	3	1	1	Pass
80-1000	90°	Horizontal	3	1	1	Pass
80-1000	180°	Horizontal	3	1	1	Pass
80-1000	270°	Horizontal	3	1	1	Pass
80-1000	0°	Vertical	3	1	1	Pass
80-1000	90°	Vertical	3	1	1	Pass
80-1000	180°	Vertical	3	1	1	Pass
80-1000	270°	Vertical	3	1	1	Pass

Remark: Calculated measurement uncertainty= 80MHz to 1000MHz (+3.7/ -1.3) V/m

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5.3 Electrical Fast Transient/Burst (EFT/B) immunity test

5.3.1 Schematics of the test

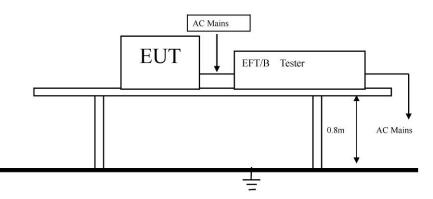


5.3.2 Test Method

The test was performed in accordance with EN 61000-4-4:2012 Severity: Level 2 (1kV)

Performance Criterion Require: B (Please see following table)

Block diagram of Test setup



5.3.3 Susceptibility performance Criteria and Severity Level

Criterion	Description
Α	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
В	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
С	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

Severity Level

	Open Circuit output Test Voltag	e ±10%
Level	On power Supply Lines	On I/O (Input/output) Signal data and control lines
1	0.5kV	0.5kV
2	1kV	1kV
3	2kV	2kV
4	4kV	4kV
Х	Special	Special

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5.3.4 Test Results

EUT Operating Environment

Temperature: 25°CHumidity: 75%RHAtmospheric Pressure: 101 kPaPlease refer to following page.

Inject location: AC mains

Inject Line	Voltage	Inject	Method	Results
	kV	Times (s)		
L	±1	120	Direct	Pass
Ν	±1	120	Direct	Pass
L-N	±1	120	Direct	Pass

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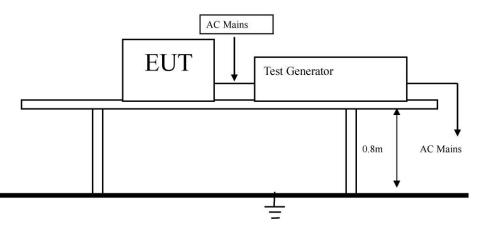
5.4 Surge test

5.4.1 Schematics of the test



5.4.2 Test Method:

The test was performed in accordance with EN 61000-4-5:2014Severity:Level 2(Line to Neutral at 1kV)Performance Criterion Require:B (Please see following table)Block diagram of Test setup



5.4.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

Criterion	Description
Α	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
В	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
С	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

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Severity L	evel
------------	------

Severity Level	Open-Circuit Test Voltage
	kV
1	0.5
2	1.0
3	2.0
4	4.0
*	Special

5.4.4 Test Results

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EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 kPa Please refer to following page.

Test location:

Location	Polarity	Phase	No of	Pulse	Results
		Angle	Pulse	Voltage(kV)	
LN	<u>+</u>	0	5	1.0	Pass
	<u>+</u>	90	5	1.0	Pass
L-N	<u>+</u>	180	5	1.0	Pass
	<u>+</u>	270	5	1.0	Pass

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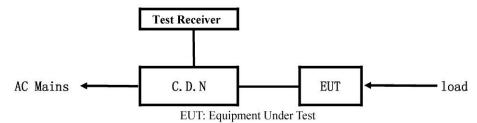
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5.5 Conducted Immunity test

5.5.1 Schematics of the test



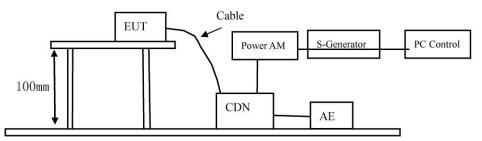
5.5.2 Test Method

The test was performed in accordance with EN 61000-4-6:2009

Severity: Level 2 (3 V rms),0.15MHz-80MHz

Performance Criterion Require: A (Please see following table)

Block diagram of Test setup



5.5.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

Criterion	Description
Α	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.
В	Degradation of performance allowed during the test the EUT returning to intended operation after the test.
С	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.

Severity Level

Severity Level	Voltage Level (e.m.f) V
1	1
2	3
3	10
*	Special

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5.5.4 Test Results:

EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 kPa Please refer to the following page

Frequency Range (MHz)	Injected Position	Strength	Criterion	Observation	Result
0.15 - 20	AC Line	3V (rms) Unmodulated	А	А	Pass
20 - 80	AC Line	3V (rms) Unmodulated	А	А	Pass

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5.6 Power-Frequency magnetic field test

5.6.1 Schematics of the test

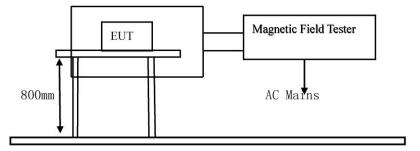


5.6.2 Test Method

The test was performed in accordance with EN 61000-4-8:2010 Severity: Level 1 (1A/m),

Performance Criterion Require: A (Please see following table)

Block diagram of Test setup



5.6.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

Criterion	Description				
Α	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.				
В	Degradation of performance allowed during the test the EUT returning to intended operation after the test.				
С	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.				

Severity Level

Severity Level	Magnetic Field Strength A/m
1	1
2	3
3	10
4	30
5	100
*	Special

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5.6.4 Test Results:

EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 kPa

Please refer to the following page

Test Level	Testing Duration	Coil Orientation	Criterion	Result
1A/m	5 Mins	Х	А	N/A
1A/m	5 Mins	Y	А	N/A
1A/m	5 Mins	Z	А	N/A

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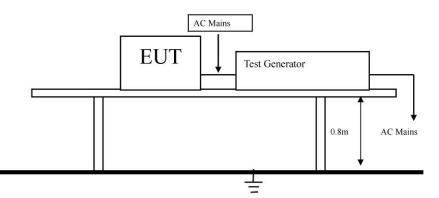
5.7 Voltage Dips/Interruptions immunity test

5.7.1 Schematics of the test



5.7.2 Test Method:

The test was performed in accordance with EN 61000-4-11:2004 Performance Criterion Require: C&B (Please see following table) **Block diagram of Test setup**



5.7.3 Susceptibility performance Criteria and Severity Level

Susceptibility performance Criteria

Criterion	Description				
Α	No change in operational mode or degradation of performance outside of specification and no change in stored parameters.				
В	Degradation of performance allowed during the test the EUT returning to intended operation after the test.				
С	Loss of function allowed during the test, provided that function is self recoverable or can be recovered by operation of controls.				

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Severity Level

	Test Level %Ut	Reduction	Duration	Performance			
Voltage			(Periods)	Criteria			
Dip	<5	>95	0.5	В			
	70	30	25	С			
Valtaas	Test Level %Ut	Reduction	Duration	Performance			
Voltage Interceptions			(Periods)	Criteria			
	<5	>95	250	С			

5.7.4 Test Result:

EUT Operating Environment

Temperature: 25°C Humidity: 75%RH Atmospheric Pressure: 101 kPa Please refer to the following page Voltage Dip:

Test Level	Reduction	Duration	Phase Angle	Meet	Result
% Ut		(periods)		Criterion	
0	100	0.5	0° - 360°	А	Pass
70	30	25	0° - 360°	А	Pass

Voltage Interceptions:

Test Level % Ut	Reduction	Duration (periods)	Phase Angle	Meet Criterion	Result
0	100	250	0° - 360°	В	Pass

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6.0 Product Labelling

6.1 CE Mark label specification

Text of the mark is black or white in color and is left justified. Labels are printed in indelible ink on permanent adhesive backing and shall be affixed at a conspicuous location on the EUT or silk-screened onto the EUT.



6.2 Mark Location: Rear enclosure

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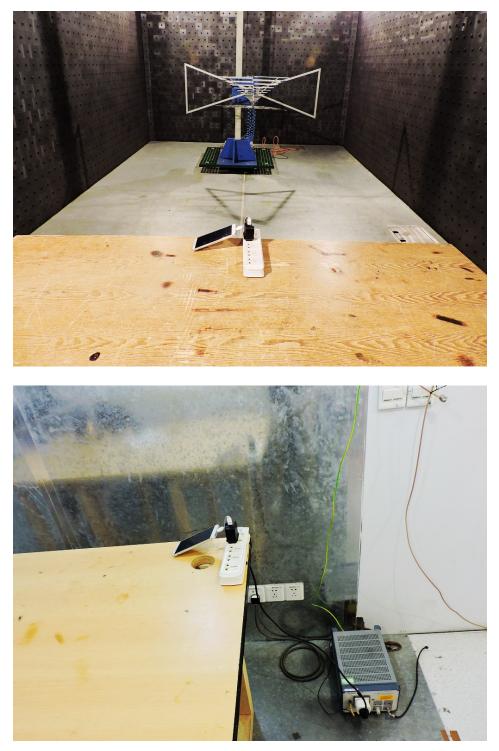
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7.0 Photo of testing

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Photo for the EUT





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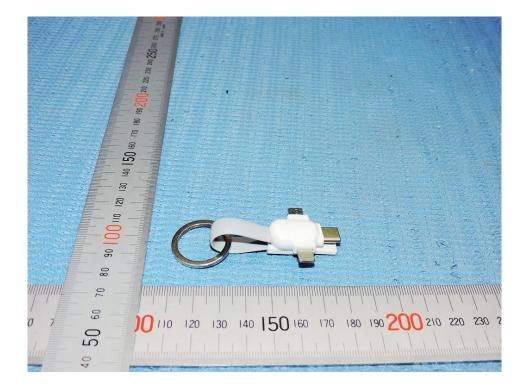
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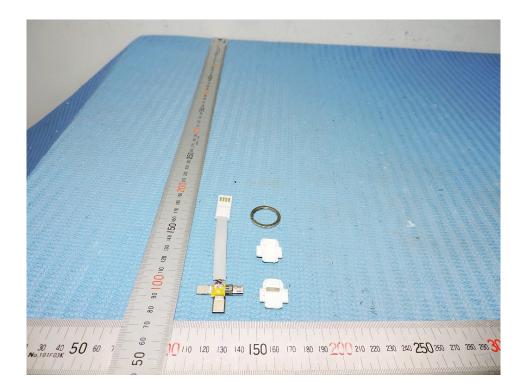
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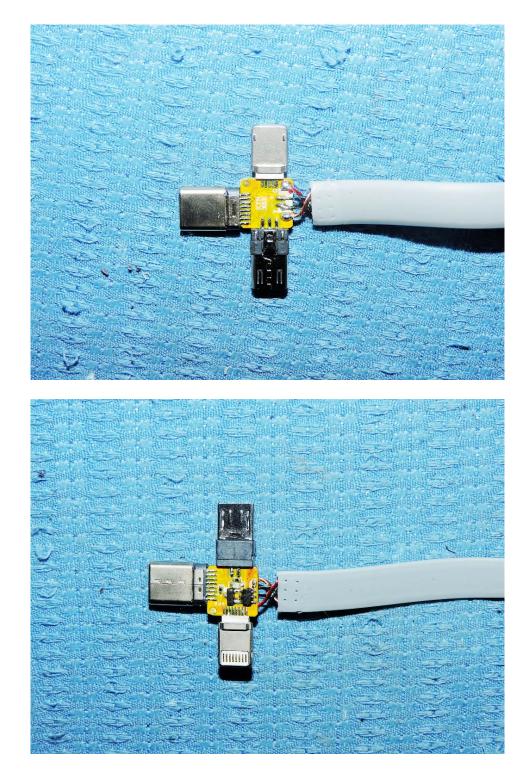
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